Search Notes

Applicant(s)/Patent under Reexamination

10/532,445

HAYES ET AL.

Examiner

Dean O. Takaoka

2817

	SEARCHED				
Class	Subclass	Date	Examiner		
333	101	9/17/2006	DT		
333	105	9/17/2006	DT		
333	262	9/18/2006	DT		
200	181	9/18/2006	DT		
updated	above	5/11/2007	DT		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
all above		5/11/2007	DT		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
east attached	9/17/2006	DT		
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